## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10609493	SHINOTSUKA ET AL.	
Examiner	Art Unit	
Carter, Aaron W	2624	

SEARCHED					
Class	Subclass	Date	Examiner		
382	274	10/24/06	AWC		
250	205	10/24/06	AWC		
345	20	10/24/06	AWC		
348	251	10/24/06	AWC		
358	461	10/24/06	AWC		
Updated Above Search		1/2/07	AWC		

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST Text Search (USPAT, PGPUB, IBM, EPO) See Search History Printout	10/24/06	AWC		
Inventor Name Search (See PALM Search History Printout, Check Marks Indicate Applications Considered)	10/24/06	AWC		
IEEE Text and Author Search, See Search History Printout	10/24/06	AWC		
Interference Search History Printout	1/2/07	AWC		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		
PGPUB Text Search		1/2/07	AWC		

U.S. Patent and Trademark Office Part of Paper No.: